


<b>Search Notes</b>  	<b>Application/Control No.</b>  10551901	<b>Applicant(s)/Patent Under Reexamination</b>  MIURA ET AL.
	<b>Examiner</b>  Jeffrey T Palenik	<b>Art Unit</b>  1615

### SEARCHED

Class	Subclass	Date	Examiner
424	489	4/7/2008	JTP
514	161, 171, 247, 252, 423	4/7/2008	JTP
424	No classified search performed.	11/13/2008	JTP
514	No classified search performed.	11/13/2008	JTP
241	No classified search performed.	11/13/2008	JTP
	No classified search performed.	5/30/2011	JTP

### SEARCH NOTES

Search Notes	Date	Examiner
Inventor search	4/7/2008	JTP
EAST search (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB	4/7/2008	JTP
Google search	4/7/2008	JTP
Inventor search updated in PALM (eDAN) and EAST	11/14/2008	JTP
EAST search updated (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) see attached history for terms searched	11/14/2008	JTP
STIC searched submitted	11/14/2008	JTP
Called EKA (an AkzoNobel company) regarding continuity between Nyacol 9950 and Bindzil 9950	9/9/2009	JTP
Google NPL search for specific surface area for silica materials (see USPGPub 2003/0220204)	9/9/2009	JTP
EAST search updated (USPGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB) see attached history for terms searched	5/30/2011	JTP

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
	(light anhydrous silicic or hydrated silicon dioxide or silicon dioxide or calcium silicate).clm. and (supercritical or subcritical) near2 carbon dioxide.clm. and pore diameter	9/12/2011	JTP

/Jeffrey T. Palenik/  
Examiner, Art Unit 1615